

<b>Notice of References Cited</b>	Application/Control No. 10/540,365	Applicant(s)/Patent Under Reexamination MORIKAWA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	354087629	07-1979	Japan	Nakazawa, Taknori et al	-----
	O	402270942	11-1990	Japan	Ueda, Masanori	-----
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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